

A status report of the SQS and SCS soft x-ray scientific instruments will be presented to the user community during this satellite meeting of the European XFEL Users meeting. The meeting starts with an update of the common SASE3 photon beam systems in a joined SQS and SCS session in the morning. After the lunch break the instrument groups will meet the users in parallel sessions to present and inform on commissioning plans, day-one instrumentations and mid-term schedule. A visit to the facility, experiment hall and SASE3 hutches will be possible on the following day during the European XFEL Users meeting. The instrument teams are happy to address further questions and share more detailed information on posters during your facility visit.

### FLASH Seminar Room Bldg. 28c, FLASH SR (Morning session)

#### SASE3 and SCS and SQS joint session

Session Chair: Serguei Molodtsov

10:00 — 10:30	Registration, Coffee		
10:30 — 11:00	Status of the SASE3 area in the experiment hall (& open port)	M. Meyer / A. Scherz	XFEL
11:00 — 11:30	X-ray beam transport and commissioning schedule	Harald Sinn	XFEL
11:30 — 12:00	Baseline, undulator gap scan, afterburner	Joachim Pflüger	XFEL
12:00 — 12:30	Advanced operation schemes, two-color, split&delay	Svitozar Serkez	XFEL

12:30 — 14:00 Lunch

### Bldg. 28c, FLASH SR | SR 4a/4b (Afternoon session 1)

#### SCS scientific instrument session

Session Chair: Andreas Scherz

14:00 — 14:30	SCS day-one instrumentation & commissioning	Manuel Izquierdo	XFEL
14:30 — 15:00	Sample environments	C. Deiter / J. Moore	XFEL
15:00 — 15:15	Short Coffee Break & Discussion		
15:15 — 15:45	Optical Laser delivery	Robert Carley	XFEL
15:45 — 16:15	XRD endstation: condense matter systems	Justine Schlappa	XFEL
16:15 — 16:45	Coffee Break & Discussion		
16:45 — 17:15	hRIXS consortium update and spectrometer design	Stefan Neppel	U Potsdam
17:15 — 18:00	Schedule, early user workshop, Discussion/Closeout	Andreas Scherz	XFEL

### Bldg. 28c, FLASH SR | SR 4a/4b (Afternoon session 2)

#### SQS scientific instrument session

Session Chair: Michael Meyer

14:00 — 14:25	KB focusing optics	T. Mazza	XFEL
14:25 — 14:50	AQS & day-one instrumentation	A. DeFanis	XFEL
14:50 — 15:15	1D-imaging XUV spectrometer	J.E. Rubensson	U Uppsala
15:15 — 15:40	FEL diagnostics & SQS control system	T. Baumann	XFEL
15:40 — 16:10	Coffee break		
16:10 — 16:35	NQS & day-one instrumentation	Y. Ovcharenko	XFEL
16:35 — 17:00	REMI	M. Schöffler	U Frankfurt
17:00 — 17:25	Instrument Laser & timing diagnostics	P. Grychtol	XFEL
17:25 — 18:00	Schedule, early user workshop, Discussion/Closeout	M. Meyer	XFEL